



100V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D T _A = +25℃
1001/	350mΩ @ V _{GS} = -10V	-2.4A
-100V	450mΩ @ V _{GS} = -6V	-2.1A

Description and Applications

This MOSFET is designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor Control
- DC-DC Converters
- Power Management Functions
- Relay and Solenoid Driving

Features and Benefits

- Fast Switching Speed
- Low Input Capacitance
- Low Gate Drive
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

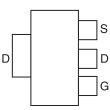
Mechanical Data

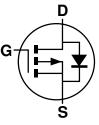
- Case: SOT223
- Case Material: Molded Plastic; UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe; Solderable per MIL-STD-202, Method 208 3
- Weight: 0.112 grams (Approximate)



SOT223

Top View





Equivalent Circuit

Ordering Information (Note 4)

Product	Case	Packaging
ZXMP10A17GTA	SOT223	1,000/Tape & Reel

Pin Out - Top

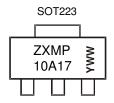
Notes: 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.

2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



ZXMP 10A17 = Product Type Marking Code YWW = Date Code Marking Y or \overline{Y} = Last Digit of Year (ex: 5= 2015) WW or \overline{WW} = Week Code (01~53)



Maximum Ratings (@T_A = +25 °C unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		V _{DSS}	-100	V	
Gate-Source Voltage		V _{GS}	±20	V	
		(Note 6)		-2.4	
Continuous Drain Current	$V_{GS} = 10V$	T _A = +70 °C (Note 6)	ID	-1.9	А
		(Note 5)		-1.7	
Pulsed Drain Current	V _{GS} = 10V	(Note 7)	IDM	-9.4	А
Continuous Source Current ((Body Diode)	(Note 6)	Is	-4.5	A
Pulsed Source Current (Bod	y Diode)	(Note 7)	I _{SM}	-9.4	А

Thermal Characteristics (@T_A = +25 °C unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Power Dissipation	(Note 5)	D	2.0 16		
Linear Derating Factor	(Note 6)	P _D	3.9 31	mW/℃	
Thermal Desistance Junction to Ambient	(Note 5)		62.5		
Thermal Resistance, Junction to Ambient	(Note 6)	R _{θJA}	32.0	°C/W	
Thermal Resistance, Junction to Case	(Note 8)	R _{θJL}	9.8		
Operating and storage temperature range		TJ, TSTG	-55 to 150	°C	

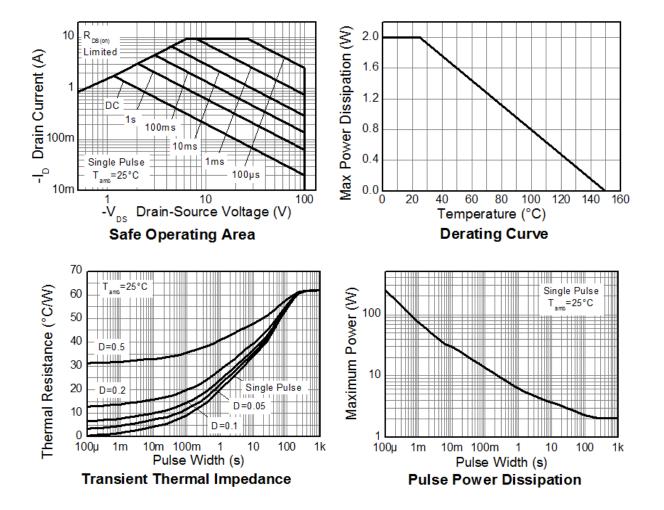
5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition. Notes:

6. Same as Note 5, except the device is measured at t \leq 10 seconds.

7. Same as Note 5, except the device is pulsed with D=0.02 and pulse width 300 μ s. The pulse current is limited by the maximum junction temperature. 8. Thermal resistance from junction to solder-point (at the end of the drain lead).



Thermal Characteristics





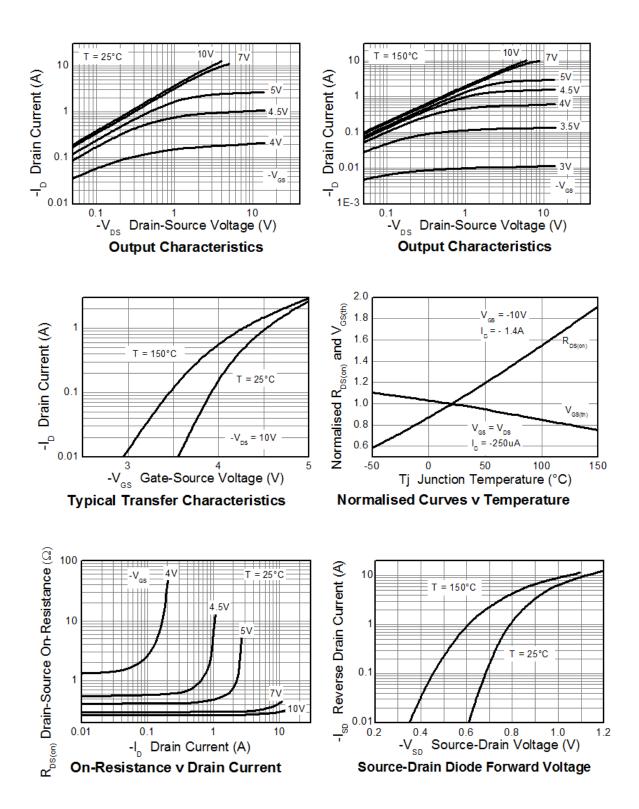
Electrical Characteristics (@T_A = +25 °C unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test	Condition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	-100			V	$I_{D} = -250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}	_		-0.5	μA	V _{DS} = -100V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_		±100	nA	V _{GS} = ±20V, V _{DS} = 0V	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	-2.0		-4.0	V	I _D = -250µA, V _{DS} = V _{GS}	
Static Drain-Source On-Resistance (Note 9)	D			0.350	Ω	V _{GS} = -10V, I _D = -1.4A	
Static Drain-Source On-Resistance (Note 9)	R _{DS (ON)}			0.450	12	V_{GS} = -6V, I_{D} =	-1.2A
Forward Transconductance (Notes 9 & 10)	g fs	—	2.8		S	V _{DS} = -15V, I _D =	-1.4A
Diode Forward Voltage (Note 9)	V _{SD}	—	-0.85	-0.95	V	I _S = -1.7A, V _{GS} = 0V	
Reverse Recovery Time (Note 10)	t _{rr}	—	33		ns	I _F = -1.5A, di/dt= 100A/µs	
Reverse Recovery Charge (Note 10)	Q _{rr}	—	48		nC		
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	C _{iss}	_	424	—	pF	−V _{DS} = -50V, V _{GS} = 0V −f= 1MHz	
Output Capacitance	C _{oss}	_	36.6		pF		
Reverse Transfer Capacitance	C _{rss}	_	29.8		pF	1- 110112	
Total Gate Charge (Note 11)	Qg	_	7.1		nC	V _{GS} = -6.0V	
Total Gate Charge (Note 11)	Qg	_	10.7		nC	V _{DS} = -50	
Gate-Source Charge (Note 11)	Q _{gs}	_	1.7		nC	V _{GS} = -10V	I _D = -1.4A
Gate-Drain Charge (Note 11)	Q _{gd}		3.8		nC	1	
Turn-On Delay Time (Note 11)	t _{D(on)}		3.0		ns	V _{DD} = -15V, V _{GS} = -10V I _D = -1A, R _G ≅ 6.0Ω	
Turn-On Rise Time (Note 11)	tr	_	3.5		ns		
Turn-Off Delay Time (Note 11)	t _{D(off)}		13.4		ns		
Turn-Off Fall Time (Note 11)	t _f	_	7.2		ns		

 9. Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%.
10. For design aid only, not subject to production testing.
11. Switching characteristics are independent of operating junction temperatures. Notes:

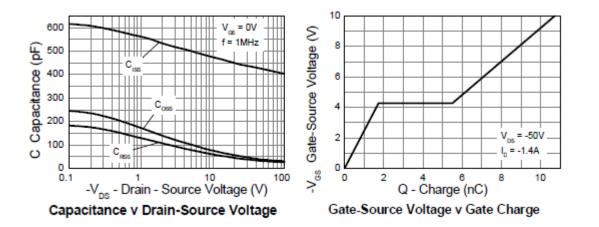


Typical Characteristics

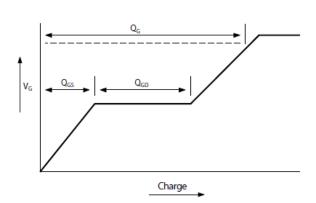




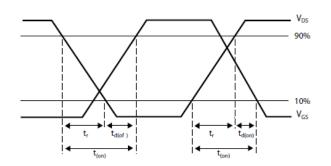
Typical Characteristics (cont.)



Test Circuits



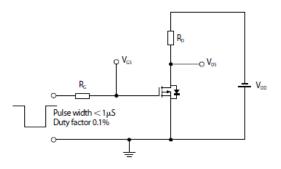
Basic gate charge waveform



Switching time waveforms

Current regulator $12V \rightarrow 0.2\mu F \rightarrow 50k$ \Rightarrow D.U.T V_{cs} D.U.T V_{cs}

Gate charge test circuit



Switching time test circuit



Тур

1.60

0.05

0.70

3.00

0.25

6.50

3.50

7.00

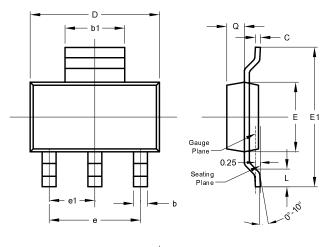
4.60

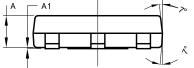
2.30 1.05 0.95

0.89

Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

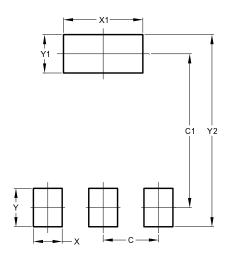




SOT223					
Dim	Min	Max	Тур		
Α	1.55	1.65	1.6		
A1	0.010	0.15	0.0		
b	0.60	0.80	0.7		
b1	2.90	3.10	3.0		
С	0.20	0.30	0.2		
D	6.45	6.55	6.5		
Е	3.45	3.55	3.5		
E1	6.90	7.10	7.0		
е	-	-	4.6		
e1	-	-	2.3		
L	0.85	1.05	0.9		
Q	0.84	0.94	0.8		
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	2.30
C1	6.40
Х	1.20
X1	3.30
Y	1.60
Y1	1.60
Y2	8.00



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